CLAIMS

1 1. A magnetic head including a read head element, comprising: 2 a pinned magnetic layer; 3 a free magnetic layer having a central portion thereof having a free magnetization 4 therewithin; 5 a magnetic bias layer, including a central portion thereof that is disposed across said 6 central portion of said free magnetic layer; said central portion of said bias layer being comprised of a material having an 7 8 approximately zero magnetic moment; 9 a barrier layer being disposed across said central portion of said bias layer. 1 2. A magnetic head as described in claim 1 wherein said central portion of said bias layer is comprised of an oxidized material, and said barrier layer is comprised of a material that is a 2 3 barrier to oxygen diffusion from said central portion of said bias layer. 1 A magnetic head as described in claim 2, further including a thin spacer layer that is 3. 2 disposed upon said free magnetic layer, wherein said bias layer is disposed upon said thin spacer 3 layer and said barrier layer is deposed upon said bias layer. A magnetic head as described in claim 3 wherein said barrier layer is comprised of a 1 2 material that has low electrical conductivity.

A magnetic head as described in claim 4 wherein said barrier layer is comprised of Ru or

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5.

Rh.

- 1 6. A magnetic head as described in claim 5 wherein said barrier layer is comprised of Ru
- 2 having a thickness of from approximately 5 Å to approximately 40 Å.
- 1 7. A magnetic head as described in claim 6 wherein said barrier layer has a thickness of
- 2 approximately 20 Å.
- 1 8. A magnetic head as described in claim 3 wherein said thin spacer layer is comprised of a
- 2 material that is a barrier to oxygen diffusion.
- 1 9. A magnetic head as described in claim 8 wherein said thin spacer layer is comprised of
- 2 Ru.
- 1 10. A hard disk drive including a magnetic head including a read head element, comprising:
- a pinned magnetic layer;
 - a free magnetic layer having a central portion thereof having a free magnetization
- 4 therewithin;
- a magnetic bias layer, including a central portion thereof that is disposed across said
- 6 central portion of said free magnetic layer;
- 7 said central portion of said bias layer being comprised of a material having an
- 8 approximately zero magnetic moment;
- 9 a barrier layer being disposed across said central portion of said bias layer.

- 1 11. A magnetic head as described in claim 10 wherein said central portion of said bias layer
- 2 is comprised of an oxidized material, and said barrier layer is comprised of a material that is a
- 3 barrier to oxygen diffusion from said central portion of said bias layer.
- 1 12. A magnetic head as described in claim 11, further including a thin spacer layer that is
- 2 disposed upon said free magnetic layer, wherein said bias layer is disposed upon said thin spacer
- 3 layer and said barrier layer is deposed upon said bias layer.
- 1 13. A magnetic head as described in claim 12 wherein said barrier layer is comprised of a
- 2 material that has low electrical conductivity.
- 1 14. A magnetic head as described in claim 13 wherein said barrier layer is comprised of Ru
- 2 or Rh.
- 1 15. A magnetic head as described in claim 14 wherein said barrier layer is comprised of Ru
- 2 having a thickness of from approximately 5 Å to approximately 40 Å.
- 1 16. A magnetic head as described in claim 15 wherein said barrier layer has a thickness of
- 2 approximately 20 Å.
- 1 17. A magnetic head as described in claim 12 wherein said thin spacer layer is comprised of a
- 2 material that is a barrier to oxygen diffusion.

- A magnetic head as described in claim 17 wherein said thin spacer layer is comprised of 1 18. 2 Ru. 1 19. A method for fabricating a magnetic head, comprising: 2 fabricating a free magnetic layer; fabricating a magnetic bias layer across said free magnetic layer; 3 4 oxidizing a central portion of said bias layer; 5 depositing an oxygen diffusion barrier layer upon said oxidized central portion of said 6 bias layer. 1 20 A method for fabricating a magnetic head as described in claim 19 wherein said barrier 2 layer is comprised of Ru or Rh.
- 1 21. A method for fabricating a magnetic head as described in claim 20 wherein said barrier
- layer is comprised of Ru and has a thickness of from approximately 5 Å to approximately 40 Å. 2
- 1 22. A method for fabricating a magnetic head as described in claim 21 wherein said barrier
- 2 layer is formed with a thickness of approximately 20 Å.